

4GB, 8GB: e·MMC

e·MMC™ Memory

MTFC4GACAJCN-1M WT, MTFC8GAKAJCN-1M WT

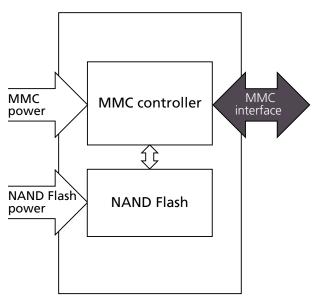
Features

- MultiMediaCard (MMC) controller and NAND Flash
- 153-ball FBGA (RoHS compliant, "green package")
- V_{CC}: 2.7-3.6V
- V_{CCQ} (dual voltage): 1.65–1.95V; 2.7–3.6V
- Temperature ranges
 - Operating temperature: –25°C to +85°C
 - Storage temperature: -40°C to +85°C

MMC-Specific Features

- JEDEC/MMC standard version 5.0-compliant (JEDEC Standard No. JESD84-B50)¹
 - Advanced 12-signal interface
 - x1, x4, and x8 I/Os, selectable by host
 - SDR/DDR modes up to 52 MHz clock speed
 - HS200/HS400 modes
 - Real-time clock
 - Command classes: class 0 (basic); class 2 (block read); class 4 (block write); class 5 (erase); class 6 (write protection); class 7 (lock card)
 - Temporary write protection
 - Boot operation (high-speed boot)
 - Sleep mode
 - Replay-protected memory block (RPMB)
 - Secure erase and secure trim
 - Hardware reset signal
 - Multiple partitions with enhanced attribute
 - Permanent and power-on write protection
 - High-priority interrupt (HPI)
 - Background operation
 - Reliable write
 - Discard and sanitize
 - Extended partitioning
 - Context ID

Figure 1: Micron e·MMC Device



MMC-Specific Features (Continued)

- Data TAG
- Packed commands
- Dynamic device capacity
- Backward compatible with previous MMC
- Cache
- Field firmware update (FFU)
- Device Health Report
- Sleep notification
- Power-off notification
- ECC and block management implemented

Note: 1. The JEDEC specification is available at www.jedec.org/sites/default/files/docs/ JESD84-B50.pdf.



4GB, 8GB: e·MMC Features

e-MMC Performance and Current Consumption

Table 1: MLC Partition Sequential Performance

	Typical Values (MB/s)				
Condition ¹	4GB	8GB			
HS400					
Write	14	22			
Read	160	190			
HS200					
Write	14	22			
Read	150	170			
DDR 52					
Write	14	20			
Read	90	90			

Note: 1. Bus in x8 I/O mode. Sequential access of 1MB chunk. Additional performance data, such as system performance on a specific application board, will be provided in a separate document upon customer request.

Table 2: MLC Partition Random Performance

	Typical Values (IOPS)					
	40	GB	86	GB		
Condition ¹	Burst	Sustained	Burst	Sustained		
HS400						
Write (Cache On)	2000 - 3500	500 - 2800	3500 - 5000	500 - 3500		
Write (Cache Off)	1000 - 1300	400 - 1100	1000 - 1300	400 - 1100		
Read	n/a	3000 - 6000	n/a	3800 - 6500		
HS200						
Write (Cache On)	2000 - 3500	500 - 2800	3000 - 4800	500 - 3500		
Write (Cache Off)	1000 - 1300	400 - 1100	1000 - 1300	400 - 1100		
Read	n/a	3000 - 6000	n/a	3500 - 6000		
DDR 52						
Write (Cache On)	2000 - 3000	500 - 2800	3000 - 4500	500 - 3500		
Write (Cache Off)	1000 - 1300	400 - 1100	1000 - 1300	400 - 1100		
Read	n/a	2500 - 5000	n/a	3000 - 5000		

Note: 1. Bus in x8 I/O mode. Random access of 4KB chunk over various spans (1GB to full card). Additional performance data, such as system performance on a specific application board, will be provided in a separate document upon customer request.



4GB, 8GB: e·MMC Features

Table 3: Current Consumption

	Typical Values (I _{CC} /I _{CCQ})			
Condition ¹	4GB	8GB	Unit	
HS400				
Write	40/70	40/70	mA	
Read	50/100	50/100	mA	
HS200				
Write	40/70	40/70	mA	
Read	50/100	50/100	mA	
DDR 52				
Write	30/60	30/60	mA	
Read	20/70	20/70	mA	
Idle/Standby				
Sleep	0/200	0/200	uA	
Auto-Standby	35/230	35/230	uA	

Note: 1. Bus in x8 I/O mode. V_{CC} = 3.6V and V_{CCQ} = 1.95V. 25°C. Measurements done as average RMS current consumption. I_{CCQ} in READ operation measurements with tester load disconnected.



4GB, 8GB: e·MMC Features

Part Numbering Information

Micron® e·MMC memory devices are available in different configurations and densities.

Figure 2: e-MMC Part Numbering

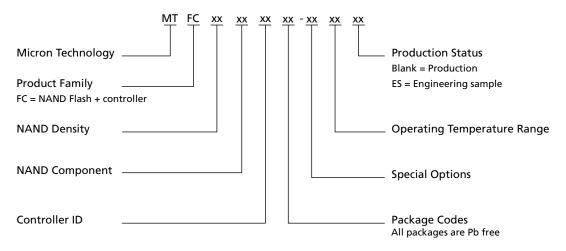


Table 4: Ordering Information

Base Part Number	Density	Package	Shipping
MTFC4GACAJCN-1M WT	4GB	153-ball VFBGA	Tray
		11.5mm x 13.0mm x 1.0mm	Tape and reel
MTFC8GAKAJCN-1M WT	8GB	153-ball VFBGA	Tray
		11.5mm x 13.0mm x 1.0mm	Tape and reel

Device Marking

Due to the size of the package, the Micron-standard part number is not printed on the top of the device. Instead, an abbreviated device mark consisting of a 5-digit alphanumeric code is used. The abbreviated device marks are cross-referenced to the Micron part numbers at the FBGA Part Marking Decoder site: www.micron.com/decoder.



4GB, 8GB: e·MMC General Description

General Description

Micron *e.*MMC is a communication and mass data storage device that includes a Multi-MediaCard (MMC) interface, a NAND Flash component, and a controller on an advanced 11-signal bus, which is compliant with the MMC system specification. Its cost per bit, small size, Flash technology independence, and high data throughput make it ideal for embedded applications like set-top boxes, digital cameras/camcorders, digital TVs, and a variety other consumer products.

The nonvolatile *e*.MMC draws no power to maintain stored data, delivers high performance across a wide range of operating temperatures, and resists shock and vibration disruption.



4GB, 8GB: e·MMC Signal Descriptions

Signal Descriptions

Table 5: Signal Descriptions

Symbol	Туре	Description
CLK	Input	Clock: Each cycle of the clock directs a transfer on the command line and on the data line(s). The frequency can vary between the minimum and the maximum clock frequency.
RST_n	Input	Reset: The RST_n signal is used by the host for resetting the device, moving the device to the pre- idle state. By default, the RST_n signal is temporarily disabled in the device. The host must set ECSD register byte 162, bits[1:0] to 0x1 to enable this functionality before the host can use it.
CMD	I/O	Command: This signal is a bidirectional command channel used for command and response transfers. The CMD signal has two bus modes: open-drain mode and push-pull mode. Commands are sent from the MMC host to the device, and responses are sent from the device to the host.
DAT[7:0]	I/O	Data I/O: These are bidirectional data signals. The DAT signals operate in push-pull mode. By default, after power-on or assertion of the RST_n signal, only DAT0 is used for data transfer. The MMC controller can configure a wider data bus for data transfer either using DAT[3:0] (4-bit mode) or DAT[7:0] (8-bit mode). The device includes internal pull-up resistors for data lines DAT[7:1]. Immediately after entering the 4-bit mode, the device disconnects the internal pull-up resistors on the DAT[3:1] lines. Upon entering the 8-bit mode, the device disconnects the internal pull-ups on the DAT[7:1] lines.
DS	Output	Data strobe: Generated by the device and used for data output and CRC status response output in HS400 mode. The frequency of this signal follows the frequency of CLK. For data output, each cycle of this signal directs two bits transfer (2x) on the data, one bit for the positive edge and the other bit for the negative edge. For CRC status response output, the CRC status is latched on the positive edge only, and is "Don't Care" on the negative edge.
V _{CC}	Supply	V _{CC} : NAND interface (I/F) I/O and NAND Flash power supply.
V _{CCQ}	Supply	V _{CCQ} : e.MMC controller core and e.MMC I/F I/O power supply.
V _{SS} ¹	Supply	V _{ss} : NAND I/F I/O and NAND Flash ground connection.
V _{SSQ} ¹	Supply	V _{SSQ} : e.MMC controller core and e.MMC I/F ground connection.
V _{DDIM}		Internal voltage node. Do not tie to supply voltage or ground.
NC	_	No connect: No internal connection is present.
RFU	_	Reserved for future use: No internal connection is present. Leave it floating externally.

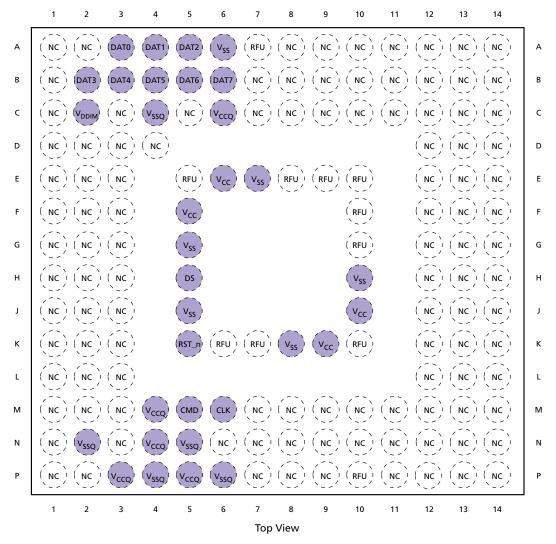
Note: 1. V_{SS} and V_{SSQ} are connected internally.



4GB, 8GB: e·MMC 153-Ball Signal Assignments

153-Ball Signal Assignments

Figure 3: 153 Ball (Top View, Ball Down)



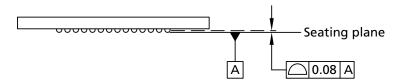
Notes:

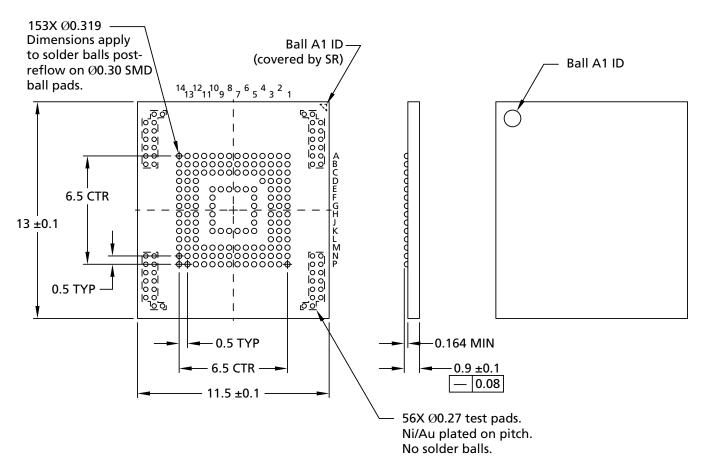
- 1. Some previous versions of the JEDEC product or mechanical specification had defined reserved for future use (RFU) balls as no connect (NC) balls. NC balls assigned in the previous specifications could have been connected to ground on the system board. To enable new feature introduction, some of these balls are assigned as RFU in the v4.4 mechanical specification. Any new PCB footprint implementations should use the new ball assignments and leave the RFU balls floating on the system board.
- 2. V_{CC}, V_{CCO}, V_{SS}, and V_{SSO} balls must all be connected on the system board.



Package Dimensions

Figure 4: 153-Ball VFBGA - 11.5mm x 13.0mm x 1.0mm (Package code CN)





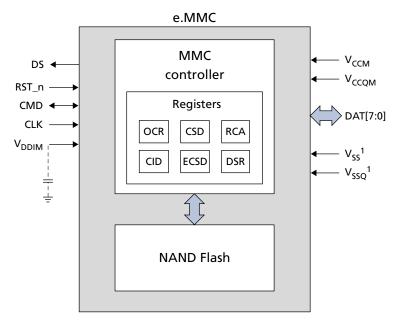
Note: 1. Dimensions are in millimeters.



4GB, 8GB: e·MMC Architecture

Architecture

Figure 5: e.MMC Functional Block Diagram



Note: 1. V_{SS} and V_{SSQ} are internally connected.

MMC Protocol Independent of NAND Flash Technology

The MMC specification defines the communication protocol between a host and a device. The protocol is independent of the NAND Flash features included in the device. The device has an intelligent on-board controller that manages the MMC communication protocol.

The controller also handles block management functions such as logical block allocation and wear leveling. These management functions require complex algorithms and depend entirely on NAND Flash technology (generation or memory cell type).

The device handles these management functions internally, making them invisible to the host processor.

Defect and Error Management

Micron *e*.MMC incorporates advanced technology for defect and error management. If a defective block is identified, the device completely replaces the defective block with one of the spare blocks. This process is invisible to the host and does not affect data space allocated for the user.

The device also includes a built-in error correction code (ECC) algorithm to ensure that data integrity is maintained.

To make the best use of these advanced technologies and ensure proper data loading and storage over the life of the device, the host must exercise the following precautions:

- Check the status after WRITE, READ, and ERASE operations.
- Avoid power-down during WRITE and ERASE operations.



OCR Register

The 32-bit operation conditions register (OCR) stores the voltage profile of the card and the access mode indication. In addition, this register includes a status information bit.

Table 6: OCR Parameters

OCR Bits	OCR Value	Description
[31]	1b (ready)/0b (busy) ¹	Device power-on status bit
[30:29]	10b	Sector mode
[28:24]	0 0000b	Reserved
[23:15]	1 1111 1111b	2.7–3.6V voltage range
[14:8]	000 0000b	2.0–2.7V voltage range
[7]	1b	1.70–1.95V voltage range
[6:0]	000 0000b	Reserved

Note: 1. OCR = C0FF8080h after the device has completed power-up.



CID Register

The card identification (CID) register is 128 bits wide. It contains the device identification information used during the card identification phase as required by e.MMC protocol. Each device is created with a unique identification number.

Table 7: CID Register Field Parameters

Name	Field	Width	CID Bits	CID Value
Manufacturer ID	MID	8	[127:120]	13h
Reserved	_	6	[119:114]	_
Card/BGA	CBX	2	[113:112]	01h
OEM/application ID	OID	8	[111:104]	-
Product name	PNM	48	[103:56]	-
Product revision	PRV	8	[55:48]	-
Product serial number	PSN	32	[47:16]	_
Manufacturing date	MDT	8	[15:8]	_
CRC7 checksum	CRC	7	[7:1]	_
Not used; always 1	_	1	[0]	_



CSD Register

The card-specific data (CSD) register provides information about accessing the device contents. The CSD register defines the data format, error correction type, maximum data access time, and data transfer speed, as well as whether the DS register can be used. The programmable part of the register (entries marked with W or E in the following table) can be changed by the PROGRAM_CSD (CMD27) command.

Table 8: CSD Register Field Parameters

Name	Field	Size (Bits)	Cell Type ¹	CSD Bits	CSD Value
CSD structure	CSD_STRUCTURE	2	R		
		4		[127:126]	3h 4h
System specification version	SPEC_VERS	2	R	[125:122]	
Reserved ²			-	[121:120]	-
Data read access time 1	TAAC	8	R	[119:112]	2Fh
Data read access time 2 in CLK cycles (NSAC × 100)	NSAC	8	R	[111:104]	01h
Maximum bus clock frequency	TRAN_SPEED	8	R	[103:96]	32h
Card command classes	ccc	12	R	[95:84]	0F5h
Maximum read data block length	READ_BL_LEN	4	R	[83:80]	9h
Partial blocks for reads supported	READ_BL_PARTIAL	1	R	[79]	0h
Write block misalignment	WRITE_BLK_MISALIGN	1	R	[78]	0h
Read block misalignment	READ_BLK_MISALIGN	1	R	[77]	0h
DSR implemented	DSR_IMP	1	R	[76]	1h
Reserved	_	2	_	[75:74]	_
Device size	C_SIZE	12	R	[73:62]	FFFh
Maximum read current at V _{DD,min}	VDD_R_CURR_MIN	3	R	[61:59]	7h
Maximum read current at V _{DD,max}	VDD_R_CURR_MAX	3	R	[58:56]	7h
Maximum write current at V _{DD,min}	VDD_W_CURR_MIN	3	R	[55:53]	7h
Maximum write current at V _{DD,max}	VDD_W_CURR_MAX	3	R	[52:50]	7h
Device size multiplier	C_SIZE_MULT	3	R	[49:47]	7h
Erase group size	ERASE_GRP_SIZE	5	R	[46:42]	1Fh
Erase group size multiplier	ERASE_GRP_MULT	5	R	[41:37]	1Fh
Write protect group size	WP_GRP_SIZE	5	R	[36:32]	1Fh
Write protect group enable	WP_GRP_ENABLE	1	R	[31]	1h
Manufacturer default ECC	DEFAULT_ECC	2	R	[30:29]	0h
Write-speed factor	R2W_FACTOR	3	R	[28:26]	3h
Maximum write data block length	WRITE_BL_LEN	4	R	[25:22]	9h
Partial blocks for writes supported	WRITE_BL_PARTIAL	1	R	[21]	0h
Reserved	_	4	_	[20:17]	_
Content protection application	CONTENT_PROT_APP	1	R	[16]	0h
File-format group	FILE_FORMAT_GRP	1	R/W	[15]	0h
Copy flag (OTP)	COPY	1	R/W	[14]	0h



Table 8: CSD Register Field Parameters (Continued)

Name	Field	Size (Bits)	Cell Type ¹	CSD Bits	CSD Value
Permanent write protection	PERM_WRITE_PROTECT	1	R/W	[13]	0h
Temporary write protection	TMP_WRITE_PROTECT	1	R/W/E	[12]	0h
File format	FILE_FORMAT	2	R/W	[11:10]	0h
ECC	ECC	2	R/W/E	[9:8]	0h
CRC	CRC	7	R/W/E	[7:1]	-
Reserved	-	1	_	[0]	_

Notes: 1. R = Read-only;

R/W = One-time programmable and readable;

R/W/E = Multiple writable with value kept after a power cycle, assertion of the RST_n

signal, and any CMD0 reset, and readable

2. Reserved bits should be read as 0.



ECSD Register

The 512-byte extended card-specific data (ECSD) register defines device properties and selected modes. The most significant 320 bytes are the properties segment. This segment defines device capabilities and cannot be modified by the host. The lower 192 bytes are the modes segment. The modes segment defines the configuration in which the device is working. The host can change the properties of modes segments using the SWITCH command.

Table 9: ECSD Register Field Parameters

Extended security commands error	Name	Field		Size (Bytes)	Cell Type ²	ECSD Bytes	ECSD Value
Extended security commands error EXT_SECURITY_ERR 1	Properties Segment						-
Supported command sets S_CMD_SET 1	Reserved ³	_		6	-	[511:506]	-
HPI features	Extended security commands error	EXT_SECURITY_ERR		1	R	[505]	00h
Background operations support BKOPS_SUPPORT 1	Supported command sets	S_CMD_SET		1	R	[504]	01h
Max-packed read commands MAX_PACKED_READS 1 R [501] 3 Max-packed write commands MAX_PACKED_WRITES 1 R [500] 3 Data tag support DATA_TAG_SUPPORT 1 R [499] 0 Tag unit size TAG_UNIT_SIZE 1 R [498] 0 Tag resources size TAG_RES_SIZE 1 R [497] 0 Context management capabilities CONTEXT_CAPABILITIES 1 R [496] 0 Large Unit Size LARGE_UNIT_SIZE_M1 4G 1 R [495] 0 Large Unit Size LARGE_UNIT_SIZE_M1 4G 1 R [495] 0 Extended partitions attribute support EXT_SUPPORT 1 R [495] 0 Extended partitions attribute support EXT_SUPPORT 1 R [493] 0 Supported modes SUPPORTED_MODES 1 R [493] 0 Operation code timeout OPERATION_CODE_TIMEOUT 1 <td>HPI features</td> <td>HPI_FEATURES</td> <td></td> <td>1</td> <td>R</td> <td>[503]</td> <td>01h</td>	HPI features	HPI_FEATURES		1	R	[503]	01h
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	Device life time estimation type A	DEVICE_LIFE_TIME_EST_TYP_A		1	R	[268]	01h
	Pre-end of life information	PRE_EOL_INFO		1	R	[267]	01h
Optimal READ size OPTIMAL_READ_SIZE 1 R [266] 0	Optimal READ size	OPTIMAL_READ_SIZE		1	R	[266]	01h



Name	Field		Size (Bytes)	Cell Type ²	ECSD Bytes	ECSD Value
Optimal WRITE size	OPTIMAL_WRITE_SIZE	4G	1	R	[265]	04h
•		8G	1			08h
Optimal trim unit size	OPTIMAL_TRIM_UNIT_SIZE	l	1	R	[264]	01h
Device version	DEVICE_VERSION		2	R	[263:262]	0000h
Firmware version	FIRMWARE_VERSION		8	R	[261:254]	-
Power class for 200MHz, DDR at VCC= 3.6V	PWR_CL_DDR_200_360		1	R	[253]	00h
Cache size	CACHE_SIZE		4	R	[252:249]	000002 00h
Generic CMD6 timeout	GENERIC_CMD6_TIME		1	R	[248]	19h
Power-off notification (long) time- out	POWER_OFF_LONG_TIME		1	R	[247]	FFh
Background operations status	BKOPS_STATUS		1	R	[246]	00h
Number of correctly programmed sectors	CORRECTLY_PROG_SECTORS	NUM	4	R	[245:242]	00h
First initialization time after partitioning (first CMD1 to device ready)	INI_TIMEOUT_AP		1	R	[241]	64h
Reserved	-		1	_	[240]	-
Power class for 52 MHz, DDR at 3.6V	PWR_CL_DDR_52_360		1	R	[239]	00h
Power class for 52 MHz, DDR at 1.95V	PWR_CL_DDR_52_195		1	R	[238]	00h
Power class for 200 MHz at 1.95V	PWR_CL_200_195		1	R	[237]	00h
Power class for 200 MHz, at 1.3V	PWR_CL_200_130		1	R	[236]	00h
Minimum write performance for 8bit at 52MHz in DDR mode	MIN_PERF_DDR_W_8_52	4G 8G	1	R	[235]	0Bh 13h
Minimum read performance for 8- bit at 52 MHz in DDR mode	MIN_PERF_DDR_R_8_52		1	R	[234]	00h
Reserved	-		1	_	[233]	-
Trim multiplier	TRIM_MULT		1	R	[232]	11h
Secure feature support	SEC_FEATURE_SUPPORT		1	R	[231]	55h
Secure erase multiplier	SEC_ERASE_MULT	4G	1	R	[230]	18h
		8G				3Ah
Secure trim multiplier	SEC_TRIM_MULT	4G	1	R	[229]	18h
		8G				3Ah
Boot information	BOOT_INFO		1	R	[228]	07h
Reserved	_		1	_	[227]	-
Boot partition size	BOOT_SIZE_MULT		1	R	[226]	10h



			Size	Cell	ECSD	ECSD
Name	Field		(Bytes)	Type ²	Bytes	Value
Access size	ACC_SIZE	4G	_ 1	R	[225]	06h
		8G				07h
High-capacity erase unit size	HC_ERASE_GRP_SIZE		1	R	[224]	01h
High-capacity erase timeout	ERASE_TIMEOUT_MULT		1	R	[223]	11h
Reliable write-sector count	REL_WR_SEC_C		1	R	[222]	01h
High-capacity write protect group size	HC_WP_GRP_SIZE		1	R	[221]	10h
Sleep current (V _{CC})	S_C_VCC		1	R	[220]	08h
Sleep current (V _{CCQ})	S_C_VCCQ		1	R	[219]	08h
Production state awareness time- out	PRODUCTION_STATE_AWAR NESS_TIMEOUT	E-	1	R	[218]	14h
Sleep/awake timeout	S_A_TIMEOUT		1	R	[217]	13h
Sleep notification time	SLEEP_NOTIFICATION_TIME		1	R	[216]	0Fh
Sector Count	SEC_COUNT	4G	4	R	[215:212]	007480 00h
		8G				00E400 00h
Reserved	_	·	1	_	[211]	-
Minimum write performance for	MIN_PERF_W_8_52	4G	1	R	[210]	0Bh
8bit at 52MHz		8G				13h
Minimum read performance for 8- bit at 52 MHz	MIN_PERF_R_8_52		1	R	[209]	08h
Minimum write performance for	MIN_PERF_W_8_26_4_52	4G	1	R	[208]	0Ch
8bit at 26MHz, for 4bit at 52MHz		8G				14h
Minimum read performance for 8- bit at 26 MHz and 4-bit at 52 MHz	MIN_PERF_R_8_26_4_52		1	R	[207]	08h
Minimum write performance for	MIN_PERF_W_4_26	4G	1	R	[206]	0Bh
4bit at 26MHz		8G				13h
Minimum read performance for 4- bit at 26 MHz	MIN_PERF_R_4_26	1	1	R	[205]	08h
Reserved	_		1	_	[204]	-
Power class for 26 MHz at 3.6V	PWR_CL_26_360		1	R	[203]	00h
Power class for 52 MHz at 3.6V	PWR_CL_52_360		1	R	[202]	00h
Power class for 26 MHz at 1.95V	PWR_CL_26_195		1	R	[201]	00h
Power class for 52 MHz at 1.95V	PWR_CL_52_195		1	R	[200]	00h
Partition switching timing	PARTITION_SWITCH_TIME		1	R	[199]	03h
Out-of-interrupt busy timing	OUT_OF_INTERRUPT_TIME		1	R	[198]	0Ah
I/O driver strength	DRIVER_STRENGTH		1	R	[197]	1Fh
Device type	DEVICE_TYPE		1	R	[196]	57h



				Cell	ECSD	ECSD
Name	Field	(Bytes)	Type ²	Bytes	Value	
Reserved	_	1	_	[195]	-	
CSD structure version	CSD_STRUCTURE	1	R	[194]	02h	
Reserved	-	1	_	[193]	-	
Extended CSD revision	EXT_CSD_REV	1	R	[192]	07h	
Modes Segment						
Command set	CMD_SET	1	R/W/E_P	[191]	00h	
Reserved	_		1	_	[190]	-
Command set revision	CMD_SET_REV		1	R	[189]	00h
Reserved	-		1	_	[188]	-
Power class	POWER_CLASS		1	R/W/E_P	[187]	00h
Reserved	-		1	_	[186]	-
High-speed interface timing	HS_TIMING		1	R/W/E_P	[185]	00h
Reserved	-		1	_	[184]	-
Bus width mode	BUS_WIDTH		1	W/E_P	[183]	00h
Reserved	-		1	_	[182]	-
Erased memory content	ERASED_MEM_CONT	1	R	[181]	00h	
Reserved	_	1	_	[180]	-	
Partition configuration	PARTITION_CONFIG	1	R/W/E, R/W/E_P	[179]	00h	
Boot configuration protection	BOOT_CONFIG_PROT	1	R/W, R/W/C_P	[178]	00h	
Boot bus width	BOOT_BUS_WIDTH		1	R/W/E	[177]	00h
Reserved	_		1	_	[176]	-
High-density erase group definition	ERASE_GROUP_DEF		1	R/W/E_P	[175]	00h
Boot write protection status registers	BOOT_WP_STATUS	1	R	[174]	00h	
Boot area write protection register	BOOT_WP	1	R/W, R/W/C_P	[173]	00h	
Reserved	-	1	_	[172]	-	
User write protection register	USER_WP	1	R/W, R/W/C_P, R/W/E_P	[171]	00h	
Reserved	_	1	_	[170]	-	
Firmware configuration	FW_CONFIG	1	R/W	[169]	00h	
RPMB Size	RPMB_SIZE_MULT 4G		1	R	[168]	04h
					20h	
Write reliability setting register ⁴	WR_REL_SET	1	R/W	[167]	1Fh	
Write reliability parameter register	WR_REL_PARAM	1	R	[166]	15h	
SANITIZE START operation	SANITIZE_START	1	W/E_P	[165]	00h	



Name	Field		Size (Bytes)	Cell Type ²	ECSD Bytes	ECSD Value
Manually start background operations	BKOPS_START	1	W/E_P	[164]	00h	
Enable background operations handshake	BKOPS_EN	1	R/W	[163]	00h	
Hardware reset function	RST_n_FUNCTION		1	R/W	[162]	00h
HPI management	HPI_MGMT		1	R/W/E_P	[161]	00h
Partitioning support	PARTITIONING_SUPPORT		1	R	[160]	07h
Max enhanced area size	MAX_ENH_SIZE_MULT 4G 8G		3	R	[159:157]	0000E9 h 0001C8 h
Partitions attribute	PARTITIONS_ATTRIBUTE		1	R/W	[156]	00h
Partitioning setting	PARTITION_SETTING_COMP	LETED	1	R/W	[155]	00h
General-purpose partition size	GP_SIZE_MULT_GP3 GP_SIZE_MULT_GP2	GP_SIZE_MULT_GP3		R/W	[154:152] [151:149]	00h 00h
	GP_SIZE_MULT_GP1			[148:146]	00h	
	GP_SIZE_MULT_GP0			[145:143]	00h	
Enhanced user data area size	ENH_SIZE_MULT	3	R/W	[142:140]	00h	
Enhanced user data start address	ENH_START_ADDR	4	R/W	[139:136]	00h	
Reserved	_	1	_	[135]	-	
Bad block management mode	SEC_BAD_BLK_MGMNT	1	R/W	[134]	00h	
Production state awareness	PRODUCTION_STATE_AWAR	1	R/W/E	[133]	00h	
Package case temperature is controlled	TCASE_SUPPORT		1	W/E_P	[132]	00h
Periodic wake-up	PERIODIC_WAKEUP	1	R/W/E	[131]	00h	
Program CID/CSD in DDR mode support	PROGRAM_CID_CSD_DDR_SUPPORT		1	R	[130]	01h
Reserved	-		2	-	[129:128]	-
Vendor specific fields	VENDOR_SPECIFIC_FIELD		64	<vendor specific=""></vendor>	[127:64]	-
Native sector size	NATIVE_SECTOR_SIZE		1	R	[63]	00h
Sector size emulation	USE_NATIVE_SECTOR	1	R/W	[62]	00h	
Sector size	DATA_SECTOR_SIZE	1	R	[61]	00h	
1st initialization after disabling sector size emulation	INI_TIMEOUT_EMU		1	R	[60]	00h
Class 6 commands control	CLASS_6_CTRL	1	R/W/E_P	[59]	00h	
Number of addressed group to be released	DYNCAP_NEEDED		1	R	[58]	00h
Exception events control	EXCEPTION_EVENTS_CTRL	2	R/W/E_P	[57:56]	00h	



Table 9: ECSD Register Field Parameters (Continued)

			Size	Cell	ECSD	ECSD
Name	Field		(Bytes)	Type ²	Bytes	Value
Exception events status	EXCEPTION_EVENTS_STATUS		2	R	[55:54]	00h
Extended partitions attribute	EXT_PARTITIONS_ATTRIBUTE	2	R/W	[53:52]	00h	
Context configuration	CONTEXT_CONF ID#14	15	R/W/E_P	[51]	00h	
	CONTEXT_CONF ID#13				[50]	00h
	CONTEXT_CONF ID#12	CONTEXT_CONF ID#12			[49]	00h
	CONTEXT_CONF ID#11				[48]	00h
	CONTEXT_CONF ID#10				[47]	00h
	CONTEXT_CONF ID#9				[46]	00h
	CONTEXT_CONF ID#8				[45]	00h
	CONTEXT_CONF ID#7				[44]	00h
	CONTEXT_CONF ID#6				[43]	00h
	CONTEXT_CONF ID#5				[42]	00h
	CONTEXT_CONF ID#4				[41]	00h
	CONTEXT_CONF ID#3				[40]	00h
	CONTEXT_CONF ID#2				[39]	00h
	CONTEXT_CONF ID#1	CONTEXT_CONF ID#1			[38]	00h
	CONTEXT_CONF ID#0				[37]	00h
Packed command status	PACKED_COMMAND_STATUS		1	R	[36]	00h
Packed command failure index	PACKED_FAILURE_INDEX		1	R	[35]	00h
Power-off notification	POWER_OFF_NOTIFICATION	1	R/W/E_P	[34]	00h	
Control to turn the Cache ON/OFF	CACHE_CTRL		1	R/W/E_P	[33]	00h
Flushing of the cache	FLUSH_CACHE		1	W/E_P	[32]	00h
Reserved	-		1	-	[31]	-
Mode configuration	MODE_CONFIG		1	R/W/E_P	[30]	00h
Mode operation codes	MODE_OPERATION_CODES		1	W/E_P	[29]	00h
Reserved	_		2	_	[28:27]	-
Field firmware update status	FFU_STATUS		1	R	[26]	00h
Pre-loading data size	PRE_LOADING_DATA_SIZE		4	R/W/E_P	[25:22]	00h
Max pre-loading data size	MAX_PRE_LOADING_DA-	4G	4	R	[21:18]	0039C0
	TA_SIZE					00h
	8G					007000
						00h
Product state awareness enablement	PRODUCT_STATE_AWARENESS MENT	1	R/W/E & R	[17]	01h	
Secure removal type	SECURE_REMOVAL_TYPE	1	R/W/E & R	[16]	01h	
Reserved	_		16	-	[15:0]	-
				1	1	

Notes: 1. Some of the register values in this table are not valid. They will be updated in the future with the correct values.

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4GB, 8GB: e·MMC ECSD Register

2. R = Read-only;

R/W = One-time programmable and readable;

R/W/E = Multiple writable with the value kept after a power cycle, assertion of the RST_n signal, and any CMD0 reset, and readable;

R/W/C_P = Writable after the value is cleared by a power cycle and assertion of the RST_n signal (the value not cleared by CMD0 reset) and readable;

R/W/E_P = Multiple writable with the value reset after a power cycle, assertion of the RST_n signal, and any CMD0 reset, and readable;

W/E_P = Multiple writable with the value reset after power cycle, assertion of the RST_n signal, and any CMD0 reset, and not readable

- 3. Reserved bits should be read as 0.
- 4. Micron has tested power failure under best-application knowledge conditions with positive results. Customers may request a dedicated test for their specific application condition. Micron set this register during factory test and used the one-time programming option.



4GB, 8GB: e·MMC DC Electrical Specifications – Device Power

DC Electrical Specifications – Device Power

The device current consumption for various device configurations is defined in the power class fields of the ECSD register.

 V_{CC} is used for the NAND Flash device and its interface voltage; V_{CCQ} is used for the controller and the e.MMC interface voltage.

Figure 6: Device Power Diagram

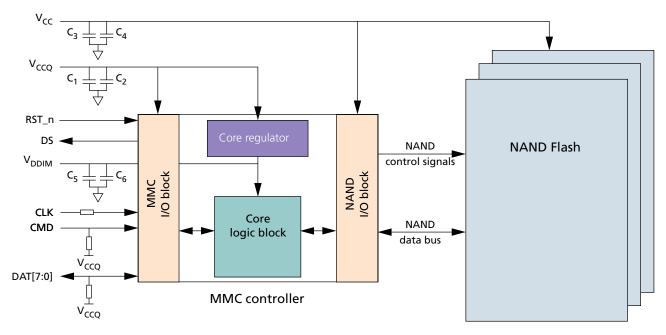


Table 10: Absolute Maximum Ratings

Parameters	Symbol	Min	Мах	Unit
Voltage input	V _{IN}	-0.6	4.6	V
V _{CC} supply	V _{CC}	-0.6	4.6	V
V _{CCQ} supply	V _{CCQ}	-0.6	4.6	V



4GB, 8GB: e·MMC **DC Electrical Specifications - Device Power**

Table 11: Capacitor and Resistance Specifications

Parameter	Symbol	Min	Мах	Тур	Units	Notes
Pull-up resistance: CMD	R_CMD	4.7	50	10	kΩ	1
Pull-up resistance: DAT[7:0]	R_DAT	10	50	50	kΩ	1
Pull-up resistance: RST_n	R_RST_n	4.7	50	50	kΩ	2
CLK/CMD/DAT[7:0] impedance		45	55	50	Ω	3
Serial resistance on CLK	SR_CLK	0	47	22	Ω	
Pull-down resistance: DS	R_DS	10	100	-	kΩ	
V _{CCQ} capacitor	C1	2.2	4.7	2.2	μF	4
	C2	0.1	0.22	0.1		
V _{CC} capacitor	C3	2.2	4.7	2.2	μF	5
	C4	0.1	0.22	0.1		
V _{DDIM} capacitor (C _{reg})	C5	1	4.7	1	μF	6
	C6	0.1	0.1	0.1		

- Notes: 1. Used to prevent bus floating.
 - 2. If host does not use H/W RESET (RST_n), pull-up resistance is not needed on RST_n line $(Extended_CSD[162] = 00h).$
 - 3. Impedance match.
 - 4. The coupling capacitor should be connected with V_{CCQ} and V_{SSQ} as closely as possible.
 - 5. The coupling capacitor should be connected with V_{CC} and V_{SS} as closely as possible.
 - 6. The coupling capacitor should be connected with V_{DDIM} and V_{SS} as closely as possible.



4GB, 8GB: e·MMC Revision History

Revision History

Rev. D - 2/16

- · Production release
- · Performance data augmented

Rev. C - 12/15

· Register Values updated

Rev. B - 10/15

· Register Values added

Rev. A - 07/15

Initial release

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This data sheet contains minimum and maximum limits specified over the power supply and temperature range set forth herein. Although considered final, these specifications are subject to change, as further product development and data characterization sometimes occur.